Small Angle X-ray Scattering Study of PS Conformation in Tetrahydrofuran Solvent with Gas Anti-solvent

Dan LI¹, Zhi Min LIU¹, Guan Ying YANG¹, Qing HUO², Bu Xing HAN¹*, Yi LIU³, Zhong Hua WU³, Bao Zhong DONG³

 Center for molecular sciences, Institute of chemistry, Chinese Academy of Science, Beijing 100080
Chemical Engineering College, Beijing Union University, Beijing 100023

3 Institute of High Energy Physics, Chinese Academy of Science, Beijing 100039

Abstract: Small angle X-ray scattering (SAXS) was used to study the effect of dissolved CO_2 on the conformation of polystyrene (PS) in PS/tetrahydrofuran(THF) solution at 308.15 K and at pressures up to 3 MPa. The cloud pressure and the expansion curve of the solution were also determined. The dependence of the conformation on pressure was discussed.

Keywords: Small angle X-ray scattering, polystyrene, THF, CO₂, conformation.

Compressed gases or supercritical fluids (SCFs) are highly soluble in some liquid solvents, and thus reduces the solvent strength of the liquids¹. As a result, precipitation of the dissolved solutes occurs, which is called as gas anti-solvent (GAS) process. Recently, this new technique has been used to produce fine particles of different compounds, such as polymers². Effect of the dissolved gases on the conformation of polymer molecules is a very interesting topic. In this work, we report the first application of small angle X-ray scattering (SAXS) to study the conformation of a polymer in the solution with a GAS.

The average molecular weight of the PS was 7.8×10^4 with a narrow molecular weight distribution (Mw/Mn=1.1), which was kindly supplied by Polymer Laboratory of Institute of Chemistry, Chinese Academy of Sciences. The concentration of PS in CO₂-free PS/THF solution was in the range from 6.74×10^{-4} to 8.36×10^{-3} g/cm³. SAXS experiments were carried out at Beamline 4B9A at Beijing Synchrotron Radiation Facility. A high pressure, temperature-controlled sample cell with two diamond windows was used. Its structure was similar to that of our UV sample cell³.

The temperature of the cell was controlled at 308.15 K. A known amount of PS/THF solution was introduced into the sample cell. CO_2 was then charged and mixed with the liquid solution under controlled pressure. Scattering measurement was performed. The scattering curve of the CO_2/THF solution without PS was also determined at the same condition, which was used as background in the data treatment.

Using the procedure reported⁴, the radii of gyration $\langle Rg^2 \rangle^{1/2}$ were obtained from the SAXS data, which reflect the conformation of polymer chains. Figure 1 shows the dependence of $\langle Rg^2 \rangle^{1/2}$ on pressure and the volume expansion (Ve= Δ V/V, V is the

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volume of gas-free solution, ΔV is the volume change caused by the dissolved CO₂) of the solution caused by anti-solvent.

Figure 1 Dependence of $\langle Rg^2 \rangle^{1/2}$ on pressure and volume expansion



It is well known that the larger the $\langle Rg^2 \rangle^{1/2}$, the more expanded the polymer is in the solution. It can be seen from **Figure 1** that $\langle Rg^2 \rangle^{1/2}$ decreases with increasing pressure, or volume expansion. It indicates that the PS chain experience shrinking in the course of adding anti-solvent CO₂. THF is a good solvent for PS and the coil expanded due to prevailing intersegmental repulsion. After adding CO₂, the solvent power of THF is reduced and PS chain shrunk due to prevailing intersegmental attraction. In addition, $\langle Rg^2 \rangle^{1/2}$ is more sensitive to pressure at the higher pressure.

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